



### 1. SCOPE

This specification shall cover the characteristics of 1-port SAW resonator with Y SR433G 211 used **fr** remote-control security.

### 2. EL ECTRICAL SPECIFICATION

### 2.1 Maximum Rating

DC Voltage VDC	10V
AC Voltage Vpp	10V 50Hz/60Hz
Operation temperature	-40°℃ to +85°℃
Storage temperature	-45°℃ to +85°℃
Max Input Power	10dBm

### 2.2 Electronic Characteristics

Item			Unites	Minimum	Typical	Maximum
Center Frequency			MHz	433.845	433.920	433.995
Insertion Loss			dB		1.8	2.2
Quality Factor		Unload Q		8300	12000	
		50Ω Loaded Q		850	1500	
Temperature	Turnov	er Temperature	°C	10	25	40
Stability Freq.te		mp.Coefficient	ppm/°C		0.032	
Frequency Aging			ppm/yr		<±10	
DC. Insulation Resistance			MΩ	1.0		
RF	Motional Resistance R1		Ω		18	26
Equivalent	Motion	al Inductance L1	μH		79.82	
RLC Model	Motion	al Capacitance C1	fF		1.685	
Transducer Static Capacitance C0			pF		2.3	

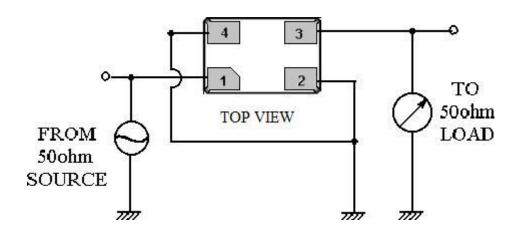


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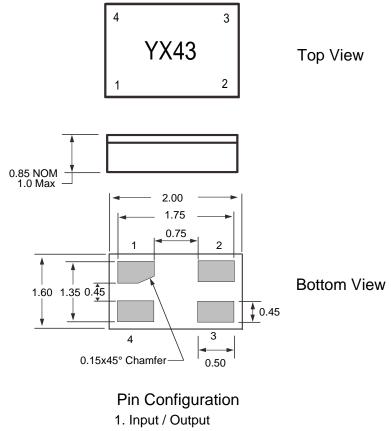




### **3. TEST CIRCUIT**



### **4. DIMENSION**



3. Output / Input 2,4. Gorund

## **5. ENVIRONMENT CHARACTERISTIC**

### 5-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2-2.

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5-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2-2.

5-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2-2.

5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2-2.

5-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2-2.

5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2-2.

5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2-2.

### 6. REMARK

6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.

### 7. PACKING

- 7.1 Dimensions
  - (1) Carrier Tape: Figure 1
  - (2) Reel: Figure 2

(3) The product shall be packed properly not to be damaged during transportation and storage.

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7.2 Reeling Quantity

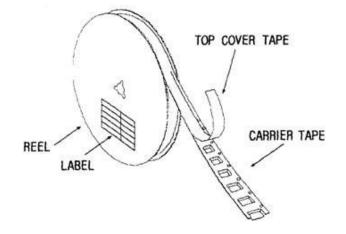
1000 pcs/reel 7"





### 7.3 Taping Structure

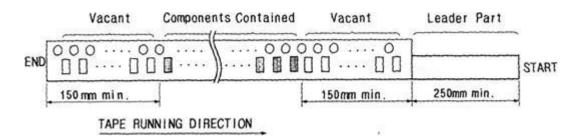
(1) The tape shall be wound around the reel in the direction shown below.



### (2) Label

Device Name	
User Product Name	
Quantity	
Lot No.	

(3) Leader part and vacant position specifications.

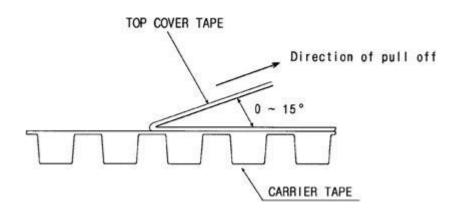


### 8. TAPE SPECIFICATIONS

8.1 Tensile Strength of Carrier Tape: 4.4N/mm width

8.2 Top Cover Tape Adhesion (See the below figure)

- (1) pull off angle: 0~15°
- (2) speed: 300mm/min.
- (3) force: 20~70g



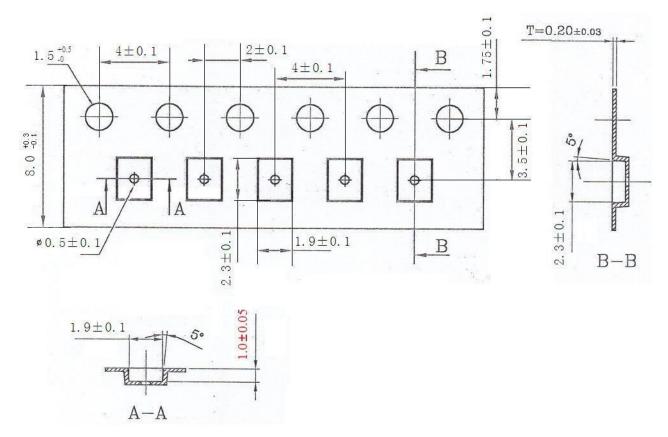
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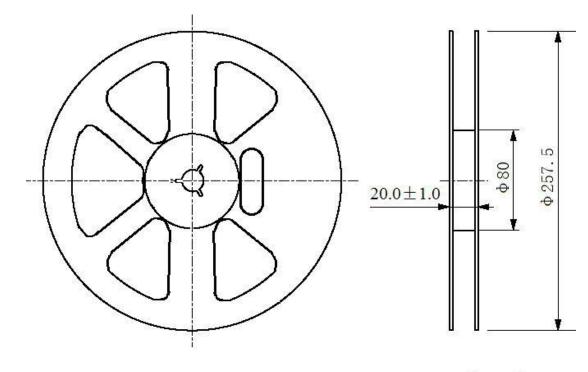
YSR433G211



### [Figure 1] Carrier Tape Dimensions



[Figure 2] 10000 pcs/reel



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 $\Phi$  257.5 Reel Dimension

(in mm)